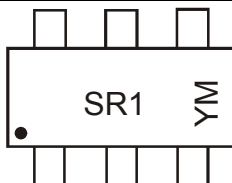


## Marking Information



SR1 = Product Type Marking Code,  
 YM = Date Code Marking  
 Y = Year, e.g., H = 2020  
 M = Month, e.g., 9 = September

### Date Code Key

Year	2010	...	2019	2020	2021	2022	2023	2024	2025	2026	2027	2028
Code	X	...	G	H	I	J	K	L	M	N	O	P

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

## Maximum Ratings @ T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P <sub>d</sub>	200	mW
Output Current	I <sub>out</sub>	200	mA

## Maximum Ratings (@ T<sub>A</sub> = +25°C, unless otherwise specified.)

### Sub-Component Device: ESD Protected N-Channel MOSFET (Q1)

Characteristic	Symbol	Value	Unit
Drain Source Voltage	V <sub>DSS</sub>	60	V
Drain Gate Voltage (RGS <+ 1MΩ)	V <sub>DGR</sub>	60	V
Gate Source Voltage Continuous	V <sub>GSS</sub>	+/-20	V
Drain Current (Note 5) Continuous (V <sub>gs</sub> =10V)	I <sub>D</sub>	200	mA

## Maximum Ratings @ T<sub>A</sub> = 25°C unless otherwise specified

### Sub-Component Device: Schottky Diode (D1)

Characteristic	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	40	V
Working Peak Reverse Voltage	V <sub>RWM</sub>		
DC Blocking Voltage	V <sub>R</sub>		
RMS Reverse Voltage	V <sub>R(RMS)</sub>	28	V
Forward Continuous Current (Note 5)	I <sub>FM</sub>	350	mA
Non-Repetitive Peak Forward Surge Current @ t<1.0 s	I <sub>FSM</sub>	1.5	A

## Thermal Characteristics

Characteristic	Symbol	Value	Unit
Junction Operation and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 to +150	°C
Thermal Resistance, Junction to Ambient Air (Note 5) (Equivalent to one heated junction of N-MOSFET)	R <sub>θJA</sub>	625	°C/W

Note: 5. Device mounted on FR-4 PCB, 1 inch square, 2oz copper pad area.

## Electrical Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Sub-Component Device: ESD Protected N-Channel MOSFET (Q1)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage, $BV_{DSS}$	$V_{BR(DSS)}$	60	—	—	V	$V_{GS} = 0V, I_D = 10\mu A$
Zero Gate Voltage Drain Current (Drain Leakage Current)	$I_{DSS}$	—	—	1	$\mu A$	$V_{GS} = 0V, V_{DS} = 60V$
Gate Body Leakage Current, Forward	$I_{GSSF}$	—	—	10	$\mu A$	$V_{GS} = 20V, V_{DS} = 0V$
Gate Body Leakage Current, Reverse	$I_{GSSR}$	—	—	-10	$\mu A$	$V_{GS} = -20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Source Threshold Voltage (Control Supply Voltage)	$V_{GS(th)}$	1	1.6	2.5	V	$V_{DS} = V_{GS}=10V, I_D = 0.25mA$
		1.1	1.8	3	V	$V_{DS} = V_{GS} = 10V, I_D = 1mA$
Static Drain-Source On-State Voltage	$V_{DS(on)}$	—	0.09	1.5	V	$V_{GS} = 5V, I_D = 50mA$
		—	0.62	1.25	V	$V_{GS} = 10V, I_D = 500mA$
Static Drain-Source On Resistance	$R_{DS(on)}$	—	1.6	3	$\Omega$	$V_{GS} = 5V, I_D= 50mA$
		—	1.5	2		$V_{GS} = 10V, I_D = 500mA$
Forward Transconductance	$g_{FS}$	80	420	—	mS	$V_{DS} \geq 2 \cdot V_{DS(ON)}, I_D=200mA$
Dynamic Characteristics						
Input Capacitance	$C_{iss}$	—	—	50	pF	$V_{DS} = 25V, V_{GS} = 0V, f = 1MHz$
Output Capacitance	$C_{oss}$	—	—	25	pF	
Reverse Transfer Capacitance	$C_{rss}$	—	—	5	pF	
Switching Characteristics						
Turn-On Delay Time	$t_{d(on)}$	—	—	20	ns	—
Turn-Off Delay Time	$t_{d(off)}$	—		40	ns	—
Drain-Source (Body) Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward On-Voltage	$V_{SD}$	—	0.88	1.5	V	$V_{GS} = 0V, I_S = 300mA$

## Electrical Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Sub-Component Device: Schottky Barrier Diode (D1)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
Reverse Breakdown Voltage (Note 6)	$V_{(BR)R}$	40	—	—	V	$I_R = 10\mu A$
Forward Voltage Drop (Note 6)	$V_{FM}$	—	—	0.37	V	$I_F = 20mA$
		—	—	0.6		$I_F = 200mA$
Peak Reverse Current (Note 6)	$I_{RM}$	—	—	5	$\mu A$	$V_R = 30V$
Total Capacitance	$C_T$	—	39	—	pF	$V_R = 0V, f = 1.0MHz$
Reverse Recovery Time	$t_{rr}$	—	10	—	ns	$I_F = I_R = 30mA, I_{rr} = 0.1 \cdot I_R, R_L = 100\Omega$

Note: 6. Short duration pulse test used to minimize self-heating effect.

## Typical Characteristics

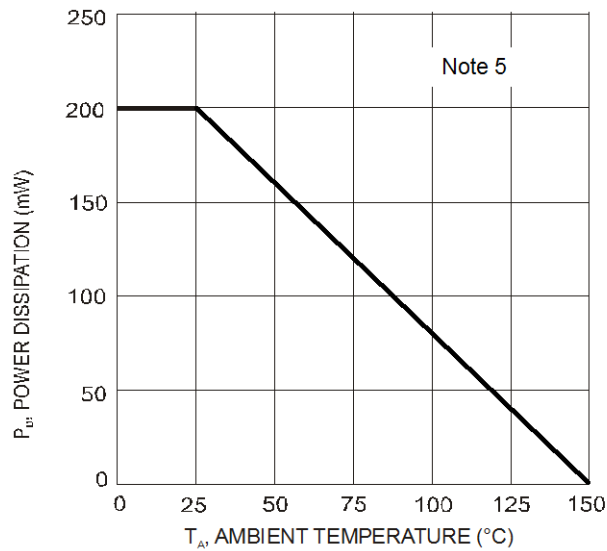


Fig. 1 Max Power Dissipation vs. Ambient Temperature

## Typical N-Channel Characteristics

Sub-Component Device: MOSFET-Q1 (ESD Protected)

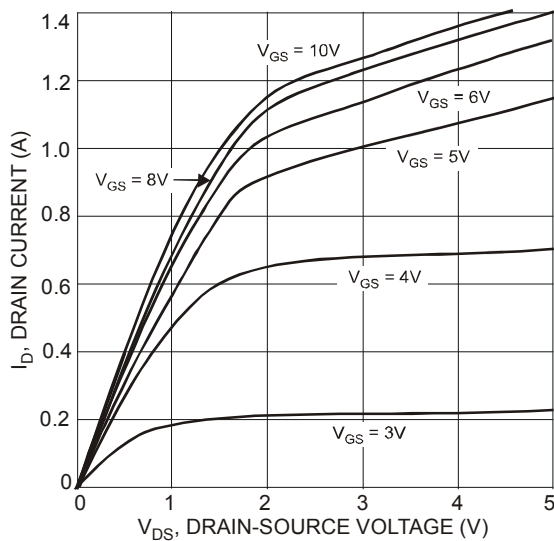


Fig. 2 Output Characteristics

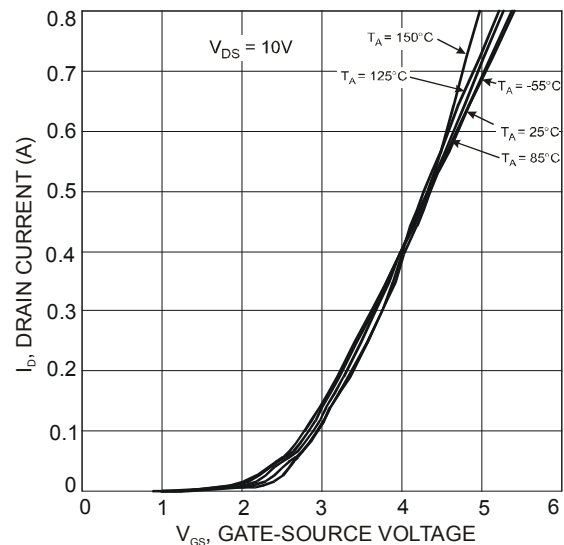


Fig. 3 Transfer Characteristics

## Typical N-Channel Characteristics (cont.)

Sub-Component Device: MOSFET-Q1 (ESD Protected)

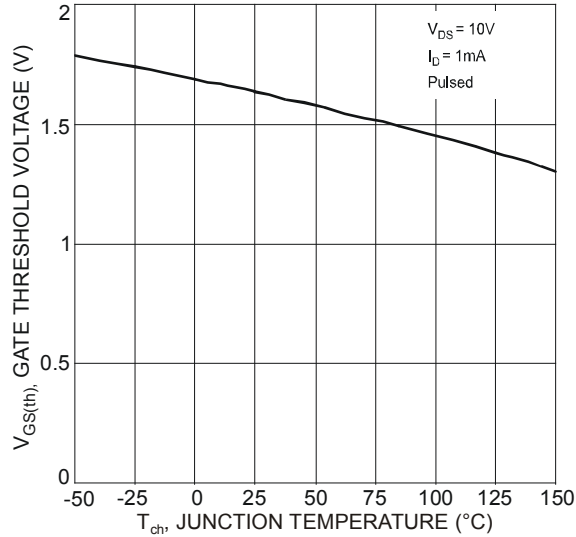


Fig. 4 Gate Threshold Voltage vs. Junction Temperature

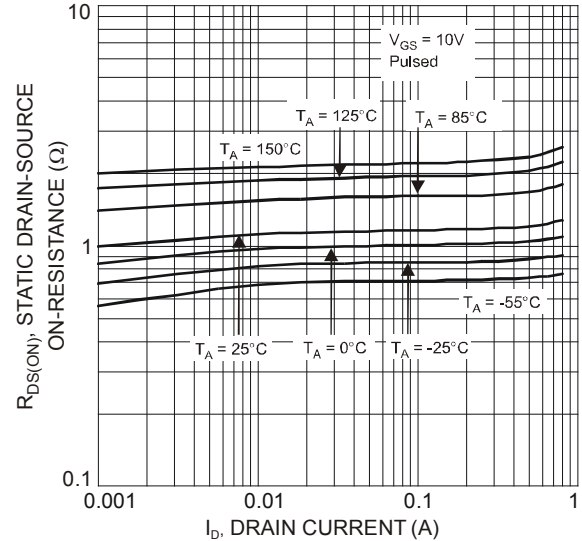


Fig. 5 Static Drain-Source On-Resistance vs. Drain Current

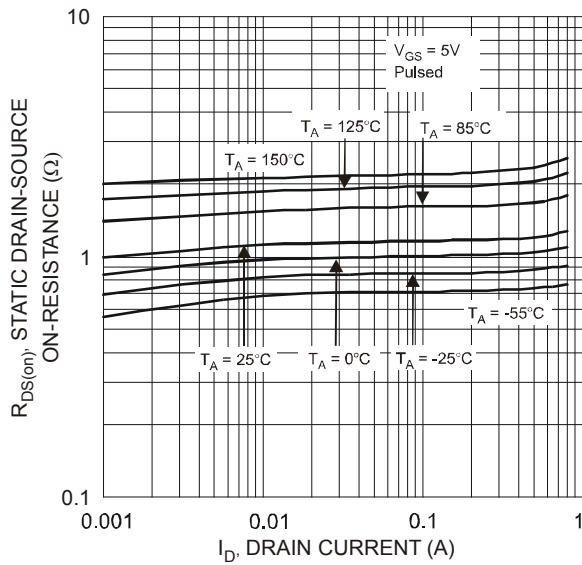


Fig. 6 Static Drain-Source On-Resistance vs. Drain Current

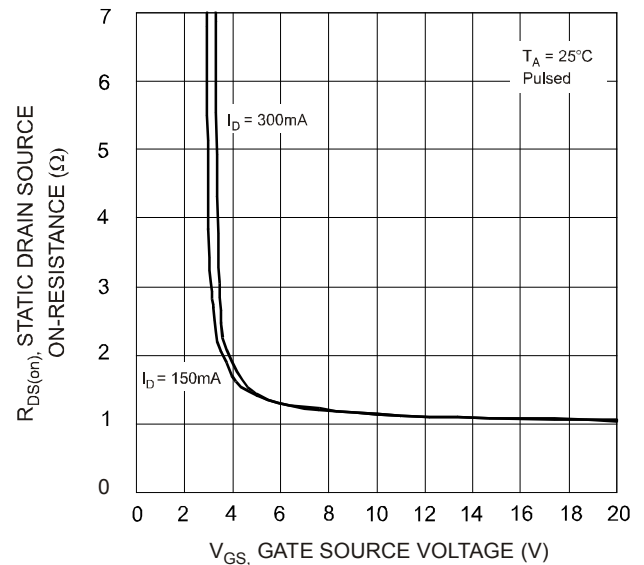


Fig. 7 Static Drain-Source On-Resistance vs. Gate-Source Voltage

# Typical N-Channel Characteristics (cont.)

Sub-Component Device: MOSFET-Q1 (ESD Protected)

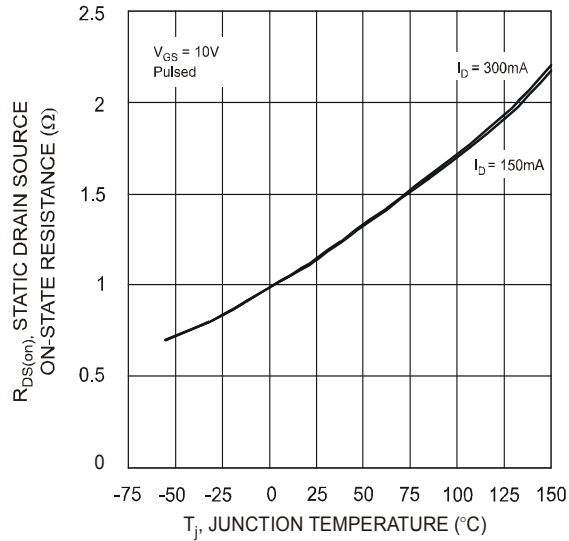


Fig. 8 Static Drain-Source On-State Resistance vs. Junction Temperature

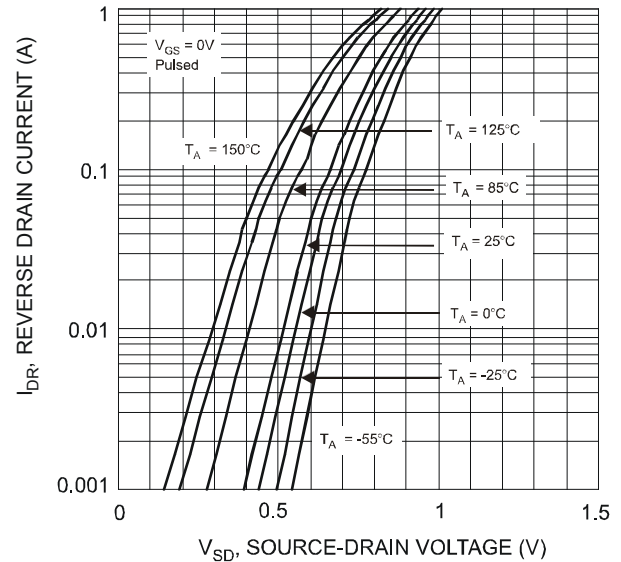


Fig. 9 Reverse Drain Current vs. Source-Drain Voltage

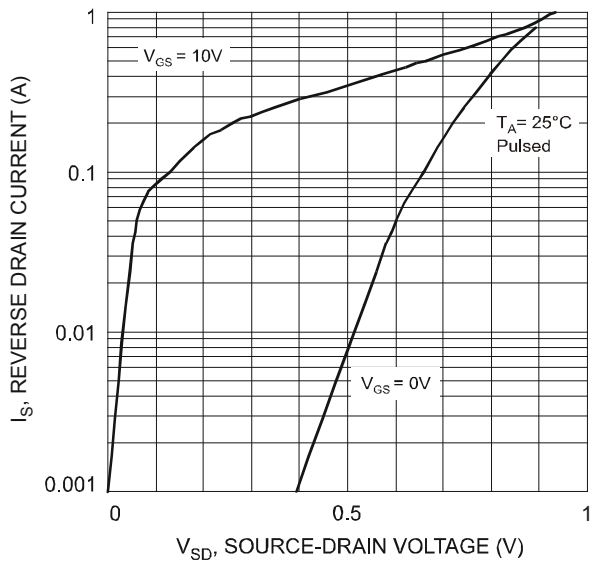


Fig. 10 Reverse Drain Current vs. Body Diode Forward Voltage

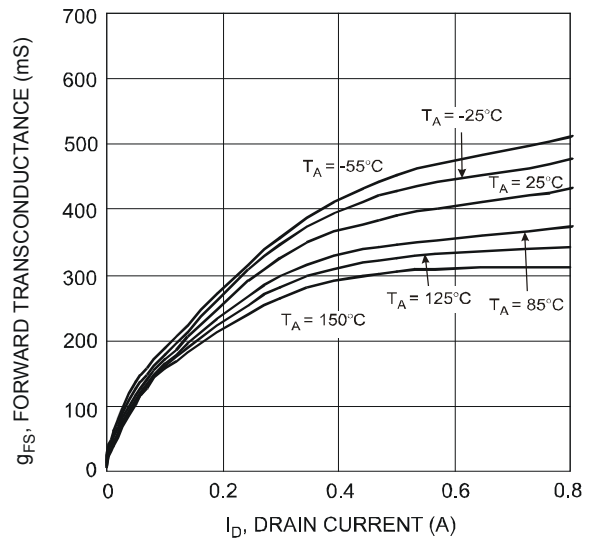


Fig. 11 Forward Transconductance vs. Drain Current ( $V_{DS} > I_D \cdot R_{DS(ON)}$ )

## Typical Characteristics

Sub-Component Device: Schottky Barrier Diode (D1)

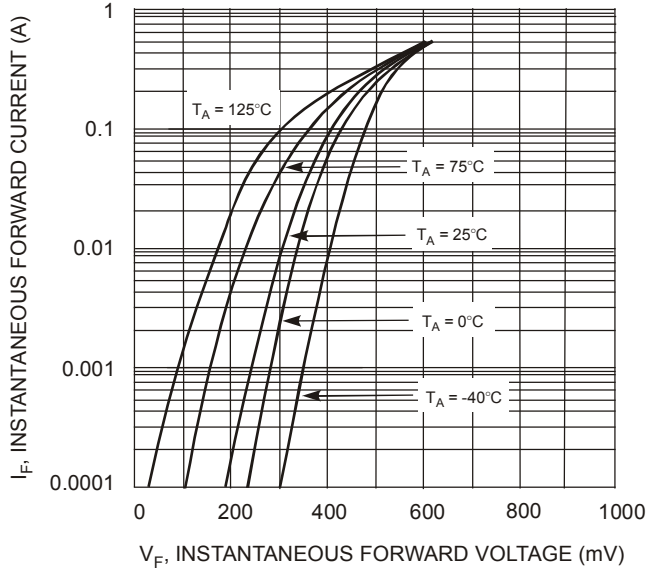


Fig. 12 Forward Characteristics

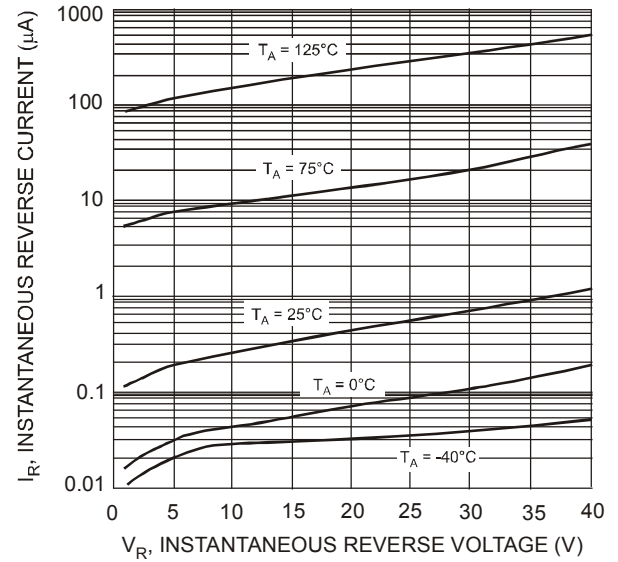


Fig. 13 Reverse Characteristics

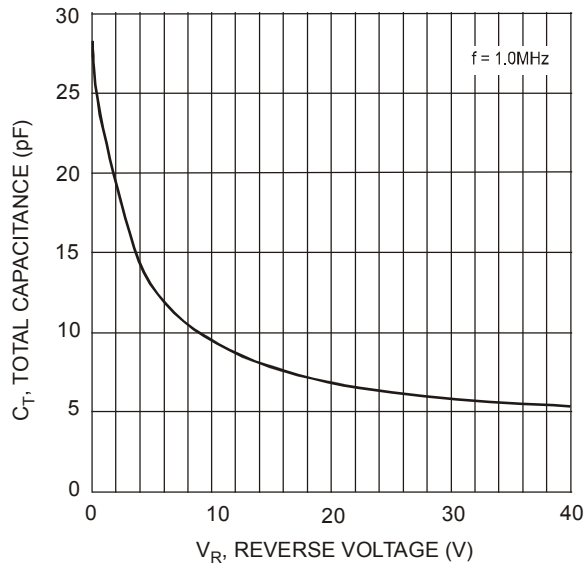
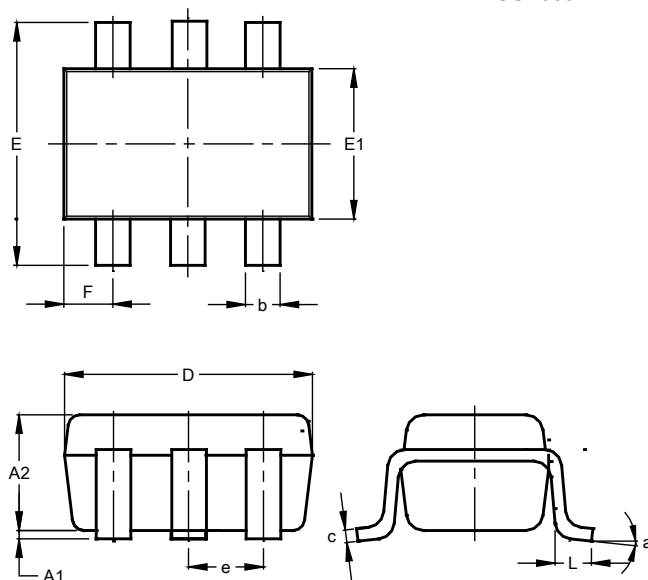


Fig. 14 Total Capacitance vs. Reverse Voltage

## Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

SOT363

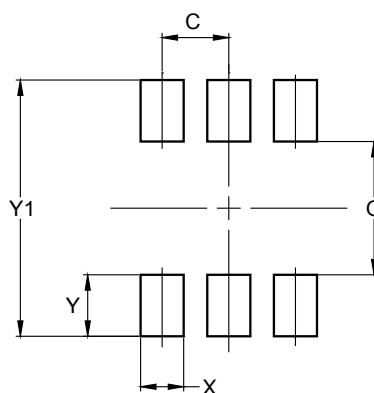


SOT363			
Dim	Min	Max	Typ
A1	0.00	0.10	0.05
A2	0.90	1.00	0.95
b	0.10	0.30	0.25
c	0.10	0.22	0.11
D	1.80	2.20	2.15
E	2.00	2.20	2.10
E1	1.15	1.35	1.30
e	0.650 BSC		
F	0.40	0.45	0.425
L	0.25	0.40	0.30
a	0°	8°	--
All Dimensions in mm			

## Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

SOT363



Dimensions	Value (in mm)
C	0.650
G	1.300
X	0.420
Y	0.600
Y1	2.500

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